PCN Numi	ber:	20230815001.1									PC	N Date:	August 15, 2023		
Title:	Title: Qualification of HFTF as an alternate Assembly site for select devices														
Customer	Customer Contact: Change Management Team Dept: Quality Services														
Proposed	1 <sup>st</sup> Shi	<b>Date:</b> Nov 13, 2023													
*Sample	reques	ts rece	ived	after	Se	pt 15,	202	3 will not l	be s	up	porte	ed.			
Change T	ype:														
	nbly Site					Desig	n				V	Wafer Bump Material			
	nbly Pro					Data						Wafer Bump Process			
	nbly Mat				Ц			er change		<u>Ц</u>		Wafer Fab Site			
	anical S				Ц	Test				<u> </u>		Wafer Fab Material			
□ Packir	ng/Shipp	oing/La	beling	]	Ш	Test				Ш	V	Wafer Fab Process			
						PC	N D	etails							
Description	on of Cl	nange:													
								e qualificati differences	s are				ional Assembly		
	Mold	Caman	d							763	,				
	MOIG	Compo	Juna					SID#EN2000763			'	SID#R-32			
	Mou	nt Com	poun	d				SID#EY1000063			}	SID#A-18			
Reason fo		ge:													
Supply cor	ntinuity														
Anticipate	ed impa	act on	Form	ı, Fit,	Fu	nction	, Qu	ality or Re	liab	ility	y (po	ositive / no	egative):		
None															
Impact or	n Enviro	onmen	tal R	ating	S										
								tal ratings for changes to							
RoHS			REACH				Green Status					62474			
☑ No Ch	ange		M	lo Cha	Change			☑ No Change				☐ No Change			
Changes	to prod	uct ide	entifi	catio	n re	sultin	g fro	m this PCI	N:						
Assembly Site Assembly Site (22L)						sembly Country Co (23L)			de	Asse	embly City				
ASESH			ASH				CHN			S		S	hanghai		
HFT	F		HFT				CHN					Hefei			
Sample pro	oduct sl	nipping	label	(not	t ac	tual p	rodu	ct label)				•			

TEXAS INSTRUMENTS MADE IN: Malaysia 2DC: 2Q: MSL 2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04

(1P) SN74LS07NSR

(Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483SI2

(P) (2P) REV: (V) 0033317 (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS

OPT: ITEM:

LBL: 5A (L)TO:3750

## **Product Affected:**

TMAG5170A1QDGKR	TMAG5170A1QDGKT	TMAG5170A2QDGKR	TMAG5170A2QDGKT
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## Qualification Report

## TMAG5170 A1/A2 ASESHAT to HFTFAT A/T offload Approve Date 21-July-2023

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	#	Test Name	Condition	Duration	Qual Device: TMAG5170A1QDGKR	Qual Device: TMAG5170A2QDGKR	QBS Reference: TMAG5170A1EDGKRQ1	QBS Reference: TMAG5170A2EDGKRQ1	QBS Reference: SN74AXC2T45QDCURQ1	QBS Reference: TLV7031QDBVRQ1
HAST	A2	Biased HAST	130C/85%RH	96 Hours	-	-	3/231/0	-	3/231/0	2/154/0
UHAST	А3	Autoclave	121C/15psig	96 Hours	-	-	3/231/0	-	3/231/0	-
UHAST	А3	Unbiased HAST	130C/85%RH	96 Hours	-	-	-	-	-	2/154/0
тс	A4	Temperature Cycle	-55C/150C	2000 Cycles	-	-	2/154/0	-	-	-
TC	A4	Temperature Cycle	-65C/150C	500 Cycles	1/77/0	-	-	-	3/231/0	2/154/0
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	-	-	-	3/135/0	-
HTSL	A6	High Temperature Storage Life	175C	1000 Hours	-	-	1/45/0	-	-	-
HTSL	A6	High Temperature Storage Life	175C	500 Hours	-	-	-	-	-	1/77/0
HTOL	B1	Life Test	125C	1000 Hours	-	-	-	-	3/231/0	-
HTOL	B1	Life Test	150C	1000 Hours	-	-	3/231/0	-	-	-
HTOL	B1	Life Test	150C	300 Hours	-	-	-	-	-	1/77/0
SD	СЗ	PB Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-	-	-	1/15/0	-	1/15/0	1/15/0

Туре	#	Test Name	Condition	Duration	Qual Device: TMAG5170A1QDGKR	Qual Device: TMAG5170A2QDGKR	QBS Reference: TMAG5170A1EDGKRQ1	QBS Reference: TMAG5170A2EDGKRQ1	QBS Reference: SN74AXC2T45QDCURQ1	QBS Reference: TLV7031QDBVRQ1
SD	СЗ	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-		-	1/15/0	-	1/15/0	1/15/0
SD	C3	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes); PB- Free Solder;	-	1/22/0	-	-	-	-	-
PD	C4	Physical Dimensions	Cpk>1.67	-	-	-	3/30/0	-	-	-
ESD	E2	ESD CDM	-	1000 Volts	-	-	-	-	-	1/3/0
ESD	E2	ESD CDM		1500 Volts	-	-	1/3/0	-	1/3/0	-
ESD	E2	ESD CDM	-	250 Volts	1/3/0	-	-	-	-	-
ESD	E2	ESD HBM	-	2000 Volts	-	-	-	-	-	1/3/0
ESD	E2	ESD HBM	-	4000 Volts	-	-	1/3/0	-	-	-
ESD	E2	ESD HBM	-	7000 Volts	-	-	-	-	1/3/0	-
LU	E4	Latch-Up	Per JESD78	-	-	-	1/6/0	-	1/6/0	1/6/0
CHAR	E5	Electrical Characterization	Per Datasheet Parameters	-	1/30/0	1/30/0	-	-	-	
CHAR	E5	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	-	-	3/90/0	1/30/0	3/90/0	3/90/0

- . OBS: Oual By Similarity
- Qual Device TMAG5170A1QDGKR is qualified at MSL2 260C
- · Qual Device TMAG5170A2QDGKR is qualified at MSL2 260C
- . Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

TI Qualification ID: R-CHG-2301-011

For questions regarding this notice, e-mails can be sent to Change Management team or your local Field Sales Representative.

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